N-Channel Power MOSFET 600 V, 2.0 Ω

Features

- Low ON Resistance
- Low Gate Charge
- ESD Diode-Protected Gate
- 100% Avalanche Tested
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

ABSOLUTE MAXIMUM RATINGS ($T_C = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	NDF	NDD	Unit
Drain-to-Source Voltage	V _{DSS}	600		V
Continuous Drain Current $R_{\theta JC}$ (Note 1)	I _D	4.8	4.1	Α
Continuous Drain Current $R_{\theta JC}$, $T_A = 100^{\circ}C$ (Note 1)	I _D	3.0	2.6	Α
Pulsed Drain Current, V _{GS} @ 10V	I _{DM}	20	20	Α
Power Dissipation $R_{\theta JC}$	P_{D}	30	83	W
Gate-to-Source Voltage	V _{GS}	±30		V
Single Pulse Avalanche Energy, I _D = 4.0	E _{AS}	120		mJ
ESD (HBM) (JESD22-A114)	V _{esd}	3000		V
RMS Isolation Voltage (t = 0.3 sec., R.H. \leq 30%, T _A = 25°C) (Figure 15)	V _{ISO}	4500	-	V
Peak Diode Recovery (Note 2)	dV/dt	4.5		V/ns
MOSFET dV/dt	dV/dt	60		V/ns
Continuous Source Current (Body Diode)	I _S	4.0		Α
Maximum Temperature for Soldering Leads	TL	T _L 260		°C
Operating Junction and Storage Temperature Range	T _J , T _{stg}	-55 to 150		°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

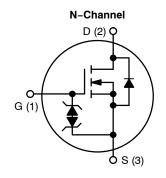
- 1. Limited by maximum junction temperature
- 2. $I_{SD} = 4.0 \text{ A}$, $di/dt \le 100 \text{ A}/\mu s$, $V_{DD} \le BV_{DSS}$, $T_J = +150^{\circ}C$



ON Semiconductor®

www.onsemi.com

V _{DSS} (@ T _{Jmax})	R _{DS(on)} (MAX) @ 2 A
650 V	2.0 Ω





NDF04N60ZG, NDF04N60ZH TO-220FP CASE 221AH



NDD04N60Z-1G IPAK CASE 369D



NDD04N60ZT4G DPAK CASE 369AA

ORDERING AND MARKING INFORMATION

See detailed ordering, marking and shipping information on page 6 of this data sheet.

THERMAL RESISTANCE

Parameter			Value	Unit
Junction-to-Case (Drain)	NDF04N60Z NDD04N60Z	$R_{ heta JC}$	4.2 1.5	°C/W
Junction-to-Ambient Steady State	(Note 3) NDF04N60Z (Note 4) NDD04N60Z (Note 3) NDD04N60Z-1	$R_{ hetaJA}$	50 38 80	

^{3.} Insertion mounted

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Characteristic	Test Conditions		Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	ı	BV _{DSS}	600			V
Breakdown Voltage Temperature Co- efficient	Reference to 25°C, $I_D = 1 \text{ mA}$		$\Delta BV_{DSS}/ \Delta T_{J}$		0.6		V/°C
Drain-to-Source Leakage Current	V _{DS} = 600 V, V _{GS} = 0 V	25°C 150°C	I _{DSS}			1 50	μΑ
Gate-to-Source Forward Leakage	V _{GS} = ±20 V	1	I _{GSS}			±10	μΑ
ON CHARACTERISTICS (Note 5)							
Static Drain-to-Source On-Resistance	$V_{GS} = 10 \text{ V}, I_D = 2.0 \text{ A}$	Ą	R _{DS(on)}		1.8	2.0	Ω
Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 50 \mu$	4	V _{GS(th)}	3.0	3.9	4.5	V
Forward Transconductance	V _{DS} = 15 V, I _D = 2.0 A	4	9FS		3.3		S
YNAMIC CHARACTERISTICS					•	•	•
Input Capacitance (Note 6)	V _{DS} = 25 V, V _{GS} = 0 V, f = 1.0 MHz		C _{iss}	427	535	640	pF
Output Capacitance (Note 6)			C _{oss}	50	62	75	
Reverse Transfer Capacitance (Note 6)			C _{rss}	8	14	20	
Total Gate Charge (Note 6)	V _{DD} = 300 V, I _D = 4.0 A,		Qg	10	19	29	nC
Gate-to-Source Charge (Note 6)			Q _{gs}	2	3.9	6	
Gate-to-Drain ("Miller") Charge	$V_{GS} = 10 \text{ V}$		Q_{gd}	5	10	15	nC
Plateau Voltage			V _{GP}		6.5		V
Gate Resistance			R_{g}		4.7		Ω
RESISTIVE SWITCHING CHARACTERI	STICS						
Turn-On Delay Time			t _{d(on)}		13		ns
Rise Time	$V_{DD} = 300 \text{ V}, I_D = 4.0 \text{ A}$	۹,	t _r		9.0		1
Turn-Off Delay Time	V_{GS} = 10 V, R_{G} = 5 Ω		t _{d(off)}		24		
Fall Time			t _f		15		
OURCE-DRAIN DIODE CHARACTER	ISTICS (T _C = 25°C unless oth	erwise not	ed)				_
Diode Forward Voltage	I _S = 4.0 A, V _{GS} = 0 V	,	V_{SD}			1.6	V
Reverse Recovery Time	$V_{GS} = 0 \text{ V}, V_{DD} = 30 \text{ V}$ $I_{S} = 4.0 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$		t _{rr}		285		ns
Reverse Recovery Charge			Q _{rr}		1.3		μС

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse Width ≤ 380 μs, Duty Cycle ≤ 2%.

6. Guaranteed by design.

^{4.} Surface mounted on FR4 board using 1" sq. pad size (Cu area = 1.127 in sq [2 oz] including traces).

TYPICAL CHARACTERISTICS

ID, DRAIN CURRENT (A)

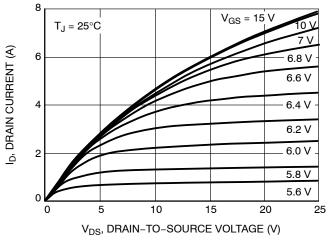
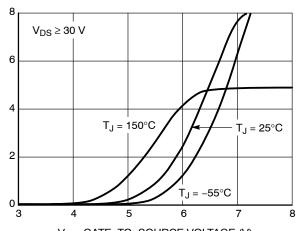


Figure 1. On-Region Characteristics



V_{GS}, GATE-TO-SOURCE VOLTAGE (V) Figure 2. Transfer Characteristics

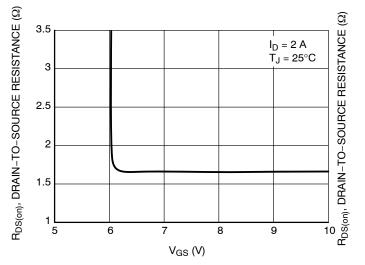


Figure 3. On-Resistance vs. Gate Voltage

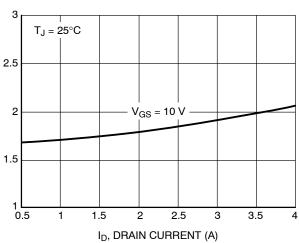


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

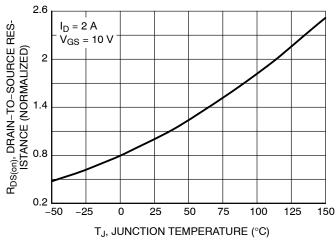


Figure 5. On–Resistance Variation with Temperature

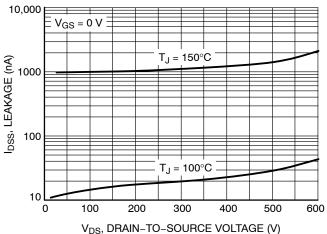
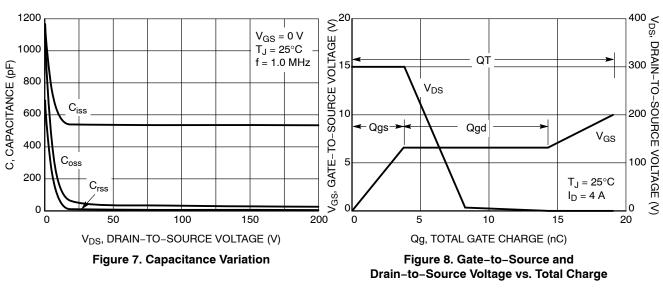


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS



SOURCE CURRENT (A)

<u>ŵ</u>

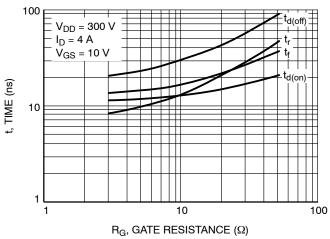


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

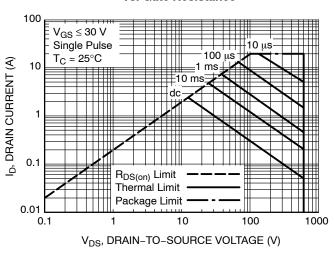


Figure 11. Maximum Rated Forward Biased Safe Operating Area for NDF04N60Z

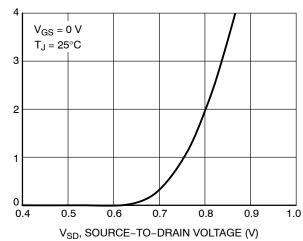


Figure 10. Diode Forward Voltage vs. Current

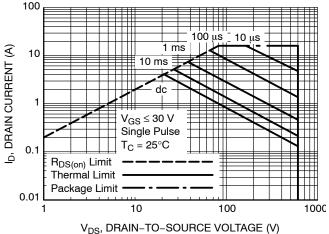


Figure 12. Maximum Rated Forward Biased Safe Operating Area for NDD04N60Z

TYPICAL CHARACTERISTICS

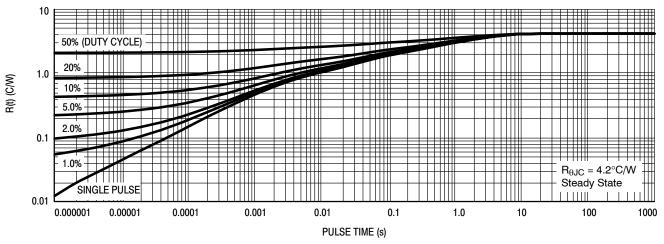


Figure 13. Thermal Impedance for NDF04N60Z

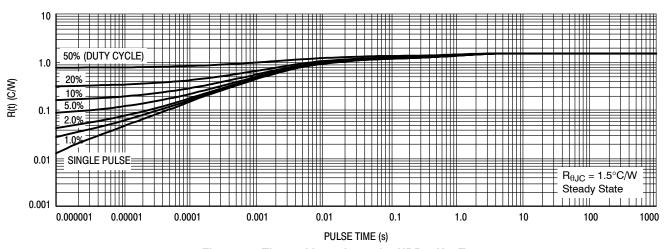


Figure 14. Thermal Impedance for NDD04N60Z

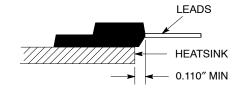


Figure 15. Mounting Position for Isolation Test

Measurement made between leads and heatsink with all leads shorted together.

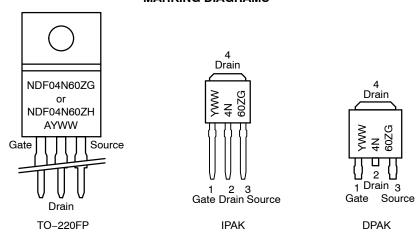
*For additional mounting information, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ORDERING INFORMATION

Order Number	Package	Shipping [†]
NDF04N60ZG	TO-220FP (Pb-Free, Halogen-Free)	50 Units / Rail
NDF04N60ZH	TO-220FP (Pb-Free, Halogen-Free)	50 Units / Rail
NDD04N60Z-1G	IPAK (Pb-Free, Halogen-Free)	75 Units / Rail
NDD04N60ZT4G	DPAK (Pb-Free, Halogen-Free)	2500 / Tape and Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

MARKING DIAGRAMS



A = Location Code Y = Year

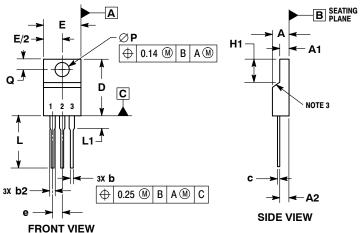
WW = Work Week

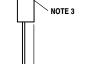
G, H = Pb-Free, Halogen-Free Package

PACKAGE DIMENSIONS

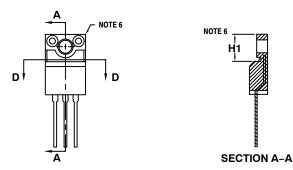
TO-220 FULLPACK, 3-LEAD

CASE 221AH **ISSUE F**









ALTERNATE CONSTRUCTION

- NOTES:

 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.

 2. CONTROLLING DIMENSION: MILLIMETERS.

 3. CONTOUR UNCONTROLLED IN THIS AREA.

 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH AND GATE PROTRUSIONS. MOLD FLASH AND GATE PROTRUSIONS NOT TO EXCEED 0.13 PER SIDE. THESE DIMENSIONS ARE TO BE MEASURED AT OUTERMOST EXTREME OF THE PLASTIC BODY.

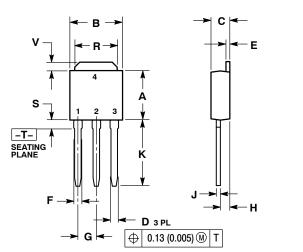
 5. DIMENSION DE DOES NOT INCLUDE DAMBAR PROTRUSION. LEAD WOTH INCLUDING PROTRUSION SHALL NOT EXCEED 2.00.

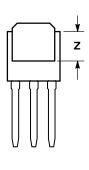
 6. CONTOURS AND FEATURES OF THE MOLDED PACKAGE BODY MAY VARY WITHIN THE ENVELOP DEFINED BY DIMENSIONS A1 AND H1 FOR MANUFACTURING PURPOSES.

	MILLIMETERS			
DIM	MIN	MAX		
Α	4.30	4.70		
A1	2.50	2.90		
A2	2.50	2.90		
b	0.54	0.84		
b2	1.10	1.40		
C	0.49	0.79		
D	14.70	15.30		
Е	9.70	10.30		
е	2.54	BSC		
H1	6.60	7.10		
L	12.50	14.73		
L1		2.80		
P	3.00	3.40		
Q	2.80	3.20		

PACKAGE DIMENSIONS

IPAK CASE 369D ISSUE C





- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.

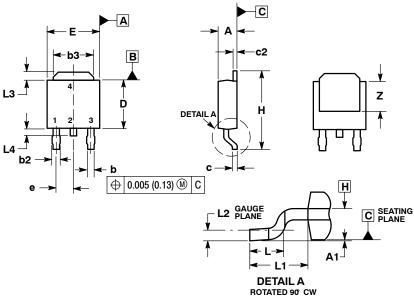
	INCHES		MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.235	0.245	5.97	6.35	
В	0.250	0.265	6.35	6.73	
С	0.086	0.094	2.19	2.38	
D	0.027	0.035	0.69	0.88	
E	0.018	0.023	0.46	0.58	
F	0.037	0.045	0.94	1.14	
G	0.090	BSC	2.29 BSC		
Н	0.034	0.040	0.87	1.01	
J	0.018	0.023	0.46	0.58	
K	0.350	0.380	8.89	9.65	
R	0.180	0.215	4.45	5.45	
S	0.025	0.040	0.63	1.01	
V	0.035	0.050	0.89	1.27	
Z	0.155		3.93		

STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

PACKAGE DIMENSIONS

DPAK (SINGLE GAUGE)

CASE 369AA **ISSUE B**

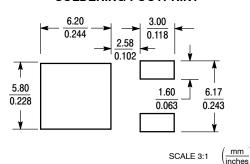


NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 2. CONTROLLING DIMENSION: INCHES.
- THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.
- DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL
- NOT EXCEED 0.006 INCHES PER SIDE.
 DIMENSIONS D AND E ARE DETERMINED AT THE
 OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PI ANF H

	INC	HES	S MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.086	0.094	2.18	2.38	
A1	0.000	0.005	0.00	0.13	
b	0.025	0.035	0.63	0.89	
b2	0.030	0.045	0.76	1.14	
b3	0.180	0.215	4.57	5.46	
С	0.018	0.024	0.46	0.61	
c2	0.018	0.024	0.46	0.61	
D	0.235	0.245	5.97	6.22	
E	0.250	0.265	6.35	6.73	
е	0.090	BSC	2.29	BSC	
Н	0.370	0.410	9.40	10.41	
L	0.055	0.070	1.40	1.78	
L1	0.108	REF	2.74 REF		
L2	0.020	BSC	0.51 BSC		
L3	0.035	0.050	0.89	1.27	
L4		0.040		1.01	
Z	0.155		3.93		

SOLDERING FOOTPRINT*



STYLE 2: PIN 1. GATE

- 2. DRAIN 3. SOURCE DRAIN

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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